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Texas Instruments High Rel Products Reliability Report

Device Type/Device Family: REF5025SHKJ/REF5025SHKQ

Package Type: 8CFP/8CSOIC

Wafer Fabrication Facility: Ti Freising

Assembly/Test Facility: Millennium Microtech

Reporting Period: 06/12

Biased Life Test

Test Method: JESD22-A108 Test Condition: 210°C / 1000 hours

Sample Size: 45 Rejects: 0

Activation Energy (eV): .5
Equivalent Device Hours: 45000
Failure Rate (FIT)*: 20491

^{* 60%} confidence level of random failure rate during nominal 1000 hour life based on test sample size. This not based on wear out failure mechanisms which will begin to affect past the 1000 hr test limit.

	Group B Tests (Wee	kly by Package Family)				
Description B1	Condition	Referenced Method	Sample Size/Rejects			
Resistance to Solvents B2		Mil Std 883 Method 2015	3/0	*		
Bond strength	Test condition F (FC)	Mil Std 883 Method 2011/2019/2027	22/0-3/0	*		
В3						
Solderability	Soldering temperature of 245C±5	Mil Std 883 Method 2003	22/0			
Group C Test (Per 3 Month Period by Family)						
Description C1	Condition	Referenced Method	Sample Size/Rejects			
Steady-state life test	125C/1000Hrs 4.6V	Mil Std 883 Method 1005				
End point electrical	•		45/0	*		

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Description D1	Group D Tests (Ann Condition	nually by Package Family) Referenced Method	Sample Size/Rejects	
Physical Dimensions		Mil Std 883 Method 2016	15/0	*
D2 Lead Integrity		Mil Std 883 Method 2004 & 2028	45/0	*
Seal(Fine and Gross)		Mil Std 883 Method 1014	45/0	*
D3		Wiction 1014		
Thermal Shock	-65°C to +150°C 15 cycles	Mil Std 883 Method 1011		
Temperature Cycle	-65°C to +150°C 100 cycles	Mil Std 883 Method 1010		*
Moisture Resistance	•	Mil Std 883 Method 1004		
Seal(Fine and Gross)		Mil Std 883		*
Visual examination		Method 1014 Mil Std 883		
Visual examination		Method 1004 &1010		
End point electrical D4			15/0	*
Mechanical Shock		Mil Std 883		
Variable Freq		Method 2002 Mil Std 883		*
Variable Freq		Method 2007		
Constant acceleration		Mil Std 883		
0 1		Method 2001		*
Seal		Mil Std 883 Method 1014		^
Visual Examination		Mil Std 883		
		Method 2009		
End point electrical D5			15/0	*
Salt Atmosphere		Mil Std 883		
Cool		Method1009		*
Seal		Mil Std 883 Method 1014		
Visual Examination		Mil Std 883	15/0	
		Method 1009		
D6				
Internal Water Vapor		Mil Std 883 Method1018	3/0	
D7				
Adhesion of Lead		Mil Std 883	15/0	
Finish		Method 2025		

Supplemental Device Characteristics

Die Revision: С Assembly Site: MMT M0SCE+5025CDAH Package Type: Master Die: HKJ/HKQ Wafer Fab: **SFAB** Pin Count: 8 Fab Technology: CMOS Mold Compound: Ceramic Fab Process: 50HPA07 Mount Compound: JM7000 Process Code: 50HPA07 Bond: ΑI Passivation: Nitride Lead Composition: Kovar Lead Finish: Au

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